

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10576806	EONNET, YVES
	<b>Examiner</b>	<b>Art Unit</b>
	MARCOS BATISTA	4134

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
455	411	3/4/2008	mb
726	27	2/4/2008	mb

<b>SEARCH NOTES</b>			
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>	
Consulted with Steve D'Agosta	3/4/2008	mb	
Consulted with TA - Yogesh Aggarwal	3/4/2008	mb	
Consulted with Lun-YI Lao	3/4/2008	mb	
East Search	3/4/2008	mb	
Inventor's Name Seach	3/4/2008	mb	
Rafael Perez Gutierrez	3/4/2008	mb	

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>